Search Notes

Applicati n/Contr I No.	Applicant(s)/Pat nt under Reexaminati n
10/631,346	AGRAWAL ET AL.
Examin r	Art Unit
Tan V. Mai	2193

SEARCHED					
Class	Subclass	Date	Examiner		
708	200	7/10/2006	MAI		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	7/10/2006	MAI		